N-Channel Power MOSFET 620 V, 0.65 Ω

ABSOLUTE MAXIMUM RATINGS (T_c = 25°C unless otherwise noted)

Features

- Low ON Resistance
- Low Gate Charge
- Zener Diode-protected Gate
- 100% Avalanche Tested
- These Devices are Pb-Free and RoHS Compliant

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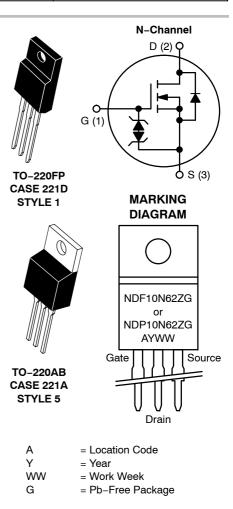
http://onsemi.com

V _{DSS}	R _{DS(ON)} (TYP) @ 5 A
620 V	0.65 Ω

Rating	Symbol	NDF10N62Z	NDP10N62Z	Unit	
Drain-to-Source Voltage	V _{DSS}	620 (Note 1)		V	
Continuous Drain Current, $R_{\theta JC}$	۱ _D	10 (Note 2)		A	
Continuous Drain Current R _{θJC} , T _A = 100°C	۱ _D	5.7 (N	ote 2)	A	
Pulsed Drain Current, V _{GS} @ 10 V	I _{DM}	36 (N	ote 2)	A	
Power Dissipation, $R_{\theta JC}$ (Note 1)	P _D	36	125	W	
Gate-to-Source Voltage	V _{GS}	±	30	V	
Single Pulse Avalanche Energy, I _D = 10 A	E _{AS}	300		mJ	
ESD (HBM) (JESD22–A114)	V _{esd}	3900		V	
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T _A = 25°C) (Figure 14)	V _{ISO}	4500		V	
Peak Diode Recovery	dv/dt	4.5 (N	ote 3)	V/ns	
Continuous Source Current (Body Diode)	I _S	10		A	
Maximum Temperature for Soldering Leads	ΤL	260		°C	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	– 55 to 150		°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface mounted on FR4 board using 1" sq. pad size,
- (Cu area = 1.127 in sq [2 oz] including traces)
- 2. Limited by maximum junction temperature
- 3. $I_{S} \leq$ 10 Å, di/dt \leq 200 Å/ $\mu s, \, V_{DD}$ = 80% BV_{DSS}



ORDERING INFORMATION

Device	Package	Shipping
NDF10N62ZG	TO-220FP	50 Units/Rail
NDP10N62ZG	TO-220AB	In Development

THERMAL RESISTANCE

Parameter	Symbol	NDF10N62Z	NDP10N62Z	Unit
Junction-to-Case (Drain)	R_{\thetaJC}	3.4	1.0	°C/W
Junction-to-Ambient Steady State (Note 4)		50	50	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

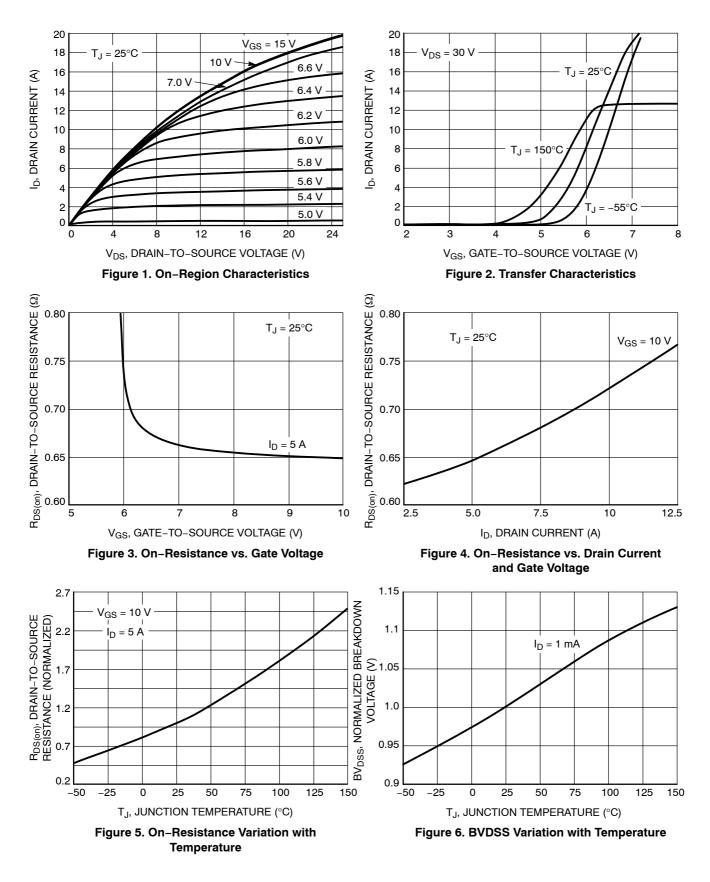
Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS			- I		-	-	-
Drain-to-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1 mA		BV _{DSS}	620			V
Breakdown Voltage Temperature Coefficient	Reference to 25°C, $I_D = 1 \text{ mA}$		$\Delta BV_{DSS}/ \Delta T_J$		0.6		V/°C
Drain-to-Source Leakage Current	N/ 000 N/ N/ 0 N/	25°C	I _{DSS}			1	μA
	V_{DS} = 620 V, V_{GS} = 0 V	125°C				50	
Gate-to-Source Forward Leakage	$V_{GS} = \pm 20 V$		I _{GSS}			±10	μA
ON CHARACTERISTICS (Note 5)							-
Static Drain-to-Source On-Resistance	V_{GS} = 10 V, I _D = 5.0 J	٩	R _{DS(on)}		0.65	0.75	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 100 \mu$	A	V _{GS(th)}	3.0	1	4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 10 A		9 _{FS}		7.9		S
OYNAMIC CHARACTERISTICS							
Input Capacitance			C _{iss}		1425		pF
Output Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		C _{oss}		150		
Reverse Transfer Capacitance			C _{rss}		35		
Total Gate Charge			Qg		47		nC
Gate-to-Source Charge	V _{DD} = 310 V, I _D = 10 /	۹,	Q _{gs}		9.3		1
Gate-to-Drain ("Miller") Charge	V _{GS} = 10 V		Q _{gd}		25		
Plateau Voltage			V _{gp}		6.4		V
Gate Resistance			Rg		1.5		Ω
ESISTIVE SWITCHING CHARACTER	ISTICS		I		-	-	-
Turn-On Delay Time			t _{d(on)}		15		ns
Rise Time	V_{DD} = 310 V, I_D = 10 A, V_{GS} = 10 V, R_G = 5 Ω		t _r		31		
			t _{d(off)}		40		
Turn-Off Delay Time		1					

Diode Forward Voltage	I _S = 10 A, V _{GS} = 0 V	V _{SD}		1.6	V
Reverse Recovery Time	$V_{GS} = 0 V, V_{DD} = 30 V$	t _{rr}	395		ns
Reverse Recovery Charge	I _S = 10 A, di/dt = 100 A/μs	Q _{rr}	3.0		μC

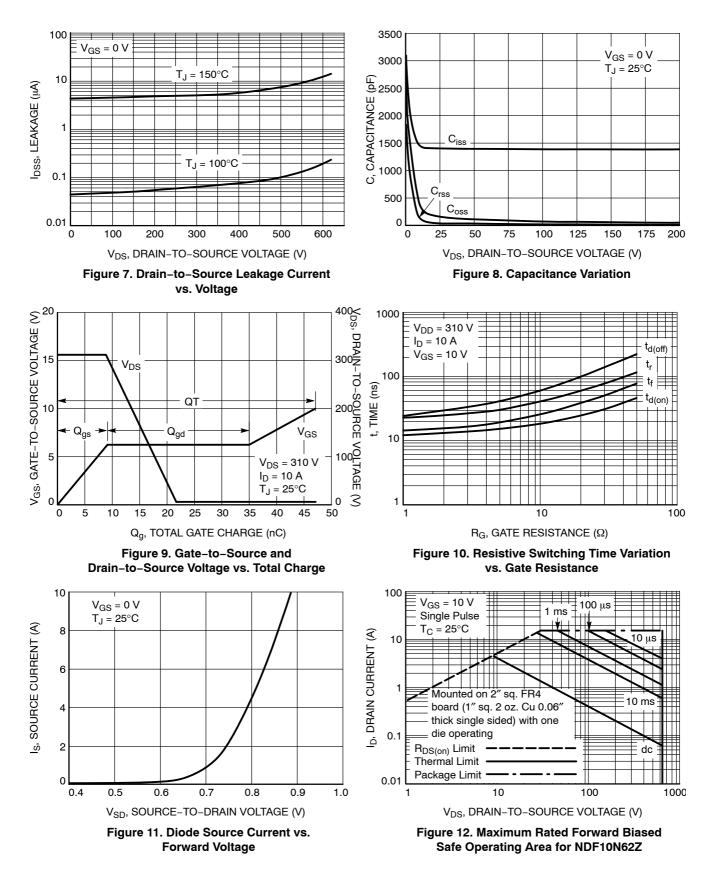
4. Insertion mounted

5. Pulse Width \leq 380 $\mu s,$ Duty Cycle \leq 2%.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

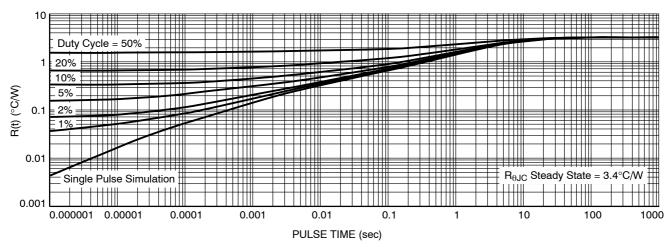
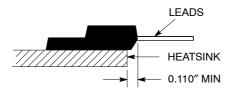


Figure 13. Thermal Impedance for NDF10N62Z



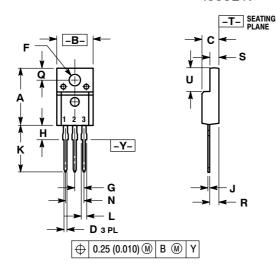


Measurement made between leads and heatsink with all leads shorted together.

*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

TO-220FP CASE 221D-03 ISSUE K



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI V14 5M 1982

Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH

 221D-01 THRU 221D-02 OBSOLETE, NEW STANDARD 221D-03.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.617	0.635	15.67	16.12
В	0.392	0.419	9.96	10.63
С	0.177	0.193	4.50	4.90
D	0.024	0.039	0.60	1.00
F	0.116	0.129	2.95	3.28
G	0.100	BSC	2.54	BSC
Н	0.118	0.135	3.00	3.43
J	0.018	0.025	0.45	0.63
K	0.503	0.541	12.78	13.73
L	0.048	0.058	1.23	1.47
Ν	0.200 BSC		5.08	BSC
Q	0.122	0.138	3.10	3.50
R	0.099	0.117	2.51	2.96
S	0.092	0.113	2.34	2.87
U	0.239	0.271	6.06	6.88

STYLE 1: PIN 1. GATE

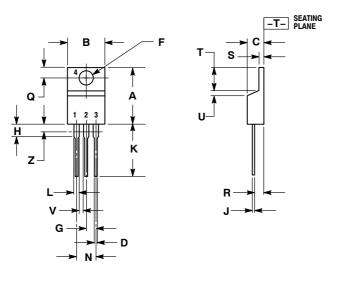
2. DRAIN

NOTES

3. SOURCE

CASE 221A-09 ISSUE AE

TO-220AB



 DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH.

 DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INC	HES	MILLIM	ETERS		
DIM	MIN	MAX	MIN	MAX		
Α	0.570	0.620	14.48	15.75		
В	0.380	0.405	9.66	10.28		
С	0.160	0.190	4.07	4.82		
D	0.025	0.035	0.64	0.88		
F	0.142	0.161	3.61	4.09		
G	0.095	0.105	2.42	2.66		
Η	0.110	0.155	2.80	3.93		
J	0.014	0.025	0.36	0.64		
Κ	0.500	0.562	12.70	14.27		
L	0.045	0.060	1.15	1.52		
Ν	0.190	0.210	4.83	5.33		
Q	0.100	0.120	2.54	3.04		
R	0.080	0.110	2.04	2.79		
S	0.045	0.055	1.15	1.39		
Т	0.235	0.255	5.97	6.47		
U	0.000	0.050	0.00	1.27		
V	0.045		1.15			
Ζ		0.080		2.04		
STYLE 5: PIN 1. GATE 2. DRAIN						

3. SOURCE 4. DRAIN

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